

SKiM® 4

IGBT Modules

SKiM601MLI07E4

Features

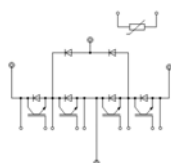
- IGBT 4 Trench Gate Technology
- Solder technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Low inductance case
- Isolated by Al_2O_3 DCB (Direct Copper Bonded) ceramic substrate
- Pressure contact technology for thermal contacts
- Spring contact system to attach driver PCB to the control terminals
- High short circuit capability, self limiting to $6 \times I_C$
- Integrated temperature sensor

Typical Applications*

- UPS
- 3 Level Inverter

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max, recommended $T_{op} = -40 \dots +150^\circ\text{C}$



MLI

Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT				
V _{CES}			650	V
I _C	T _j = 175 °C	T _s = 25 °C	438	A
		T _s = 70 °C	345	A
I _{Cnom}			600	A
I _{CRM}	I _{CRM} = 2xI _{Cnom}		1200	A
V _{GES}			-20 ... 20	V
t _{psc}	V _{CC} = 360 V V _{GE} ≤ 15 V V _{CES} ≤ 650 V	T _j = 150 °C	6	μs
T _j			-40 ... 175	°C

Inverse diode

I_F	$T_j = 175^\circ\text{C}$	$T_s = 25^\circ\text{C}$	357	A
		$T_s = 70^\circ\text{C}$	275	A
I_{Fnom}			600	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$		1200	A
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		3240	A
T_j			-40 ... 175	$^\circ\text{C}$

Clamping diode

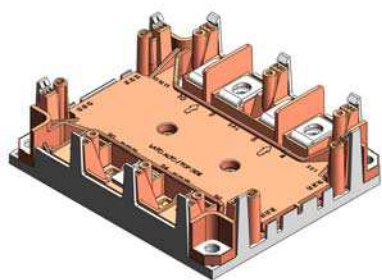
I_F	$T_j = 175^\circ\text{C}$	$T_s = 25^\circ\text{C}$	334	A
		$T_s = 70^\circ\text{C}$	256	A
I_{Fnom}			400	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$		800	A
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		2646	A
T_j			-40 ... 175	$^\circ\text{C}$

Module

$I_{t(RMS)}$	$T_{terminal} = 80^\circ\text{C}$	400	A
T_{stg}		-40 ... 125	$^\circ\text{C}$
V_{isol}	AC sinus 50 Hz, $t = 1\text{ min}$	2500	V

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 600\text{ A}$ $V_{GE} = 15\text{ V}$ chiplevel	$T_j = 25^\circ\text{C}$	1.45	1.85	V
		$T_j = 150^\circ\text{C}$	1.70	2.10	V
V_{CE0}		$T_j = 25^\circ\text{C}$	0.9	1	V
		$T_j = 150^\circ\text{C}$	0.85	0.9	V
r_{CE}	$V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}$	0.9	1.4	$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	1.4	2.0	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 9.6\text{ mA}$	5	5.8	6.5	V
I_{CES}	$V_{GE} = 0\text{ V}$ $V_{CE} = 650\text{ V}$	$T_j = 25^\circ\text{C}$			mA
		$T_j = 150^\circ\text{C}$			mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	37.01		nF
C_{oes}		$f = 1\text{ MHz}$	2.31		nF
C_{res}		$f = 1\text{ MHz}$	1.10		nF
Q_G	$V_{GE} = -8\text{ V} \dots +15\text{ V}$		4800		nC
R_{Gint}	$T_j = 25^\circ\text{C}$		0.7		Ω



SKiM® 4

IGBT Modules

SKiM601MLI07E4

Features

- IGBT 4 Trench Gate Technology
- Solder technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Low inductance case
- Isolated by Al_2O_3 DCB (Direct Copper Bonded) ceramic substrate
- Pressure contact technology for thermal contacts
- Spring contact system to attach driver PCB to the control terminals
- High short circuit capability, self limiting to $6 \times I_C$
- Integrated temperature sensor

Typical Applications*

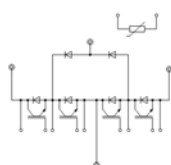
- UPS
- 3 Level Inverter

Remarks

- Case temperature limited to $T_C = 125^\circ\text{C}$ max, recommended $T_{op} = -40 \dots +150^\circ\text{C}$

Characteristics					
Symbol	Conditions		min.	typ.	max. Unit
$t_{d(on)}$	$V_{CE} = 300\text{ V}$	$T_j = 150^\circ\text{C}$		121	ns
t_r	$I_C = 600\text{ A}$	$T_j = 150^\circ\text{C}$		232	ns
E_{on}	$R_{G\ on} = 2\ \Omega$	$T_j = 150^\circ\text{C}$		6.05	mJ
$t_{d(off)}$	$R_{G\ off} = 2\ \Omega$	$T_j = 150^\circ\text{C}$		599	ns
t_f	$di/dt_{on} = 2087\text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		156	ns
E_{off}	$di/dt_{off} = 2270\text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		44	mJ
$R_{th(j-s)}$				0.19	K/W

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
V _F = V _{EC}	I _F = 600 A V _{GE} = 0 V chiplevel	T _j = 25 °C		1.5	1.9	V
		T _j = 150 °C		1.6	2.0	V
V _{F0}		T _j = 25 °C	0.95	1.04	1.236	V
		T _j = 150 °C		0.85	0.99	V
r _F		T _j = 25 °C	0.6	0.8	1.2	mΩ
		T _j = 150 °C		1.2	1.7	mΩ
I _{RRM}	V _{GE} = -15 V V _R = 300 V					A
Q _{rr}				29		μC
E _{rr}						mJ
R _{th(j-s)}		per diode			0.27	
Clamping diode						
V _F = V _{EC}	I _F = 400 A V _{GE} = 0 V chiplevel	T _j = 25 °C		1.4	1.8	V
		T _j = 150 °C		1.4	1.8	V
V _{F0}		T _j = 25 °C	0.95	1.04	1.236	V
		T _j = 150 °C		0.85	0.99	V
r _F		T _j = 25 °C	0.6	0.9	1.3	mΩ
		T _j = 150 °C		1.3	1.9	mΩ
I _{RRM}	V _{GE} = -15 V V _R = 300 V			133		A
Q _{rr}						μC
E _{rr}				2.4		mJ
R _{th(j-s)}		per diode			0.29	
Module						
L _{CE}				22		nH
R _{CC'+EE'}	terminal-chip	T _s = 25 °C		1.35		mΩ
		T _s = 125 °C		1.75		mΩ
M _s	to heat sink (M5)		2		3	Nm
M _t	to terminals M6		4		5	Nm
w				317		g
Temperature Sensor						
R ₁₀₀	T _c =100°C (R ₂₅ =5 kΩ)			493 ± 5%		Ω
B _{100/125}	R _(T) =R ₁₀₀ exp[B _{100/125} (1/T-1/T ₁₀₀)]; T[K];			3550 ±2%		K



MLI

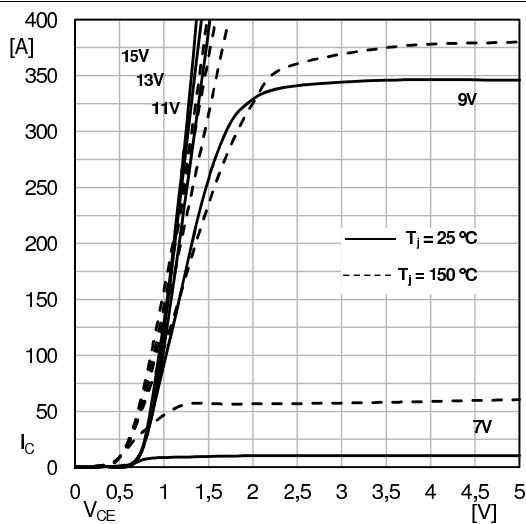


Fig. 3: Typ. IGBT output characteristic, inclusive $R_{CC'+EE'}$

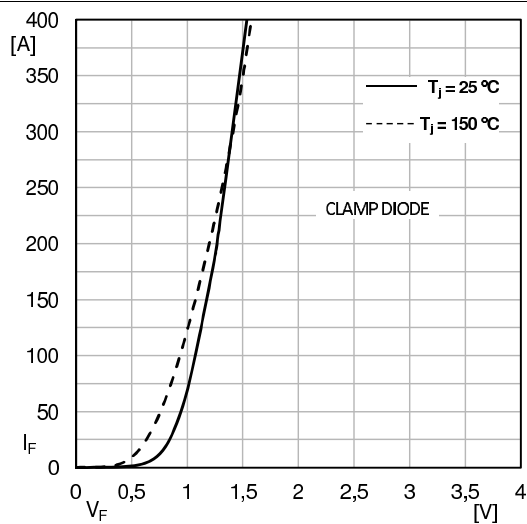


Fig. 4: Typ. Diode output characteristic

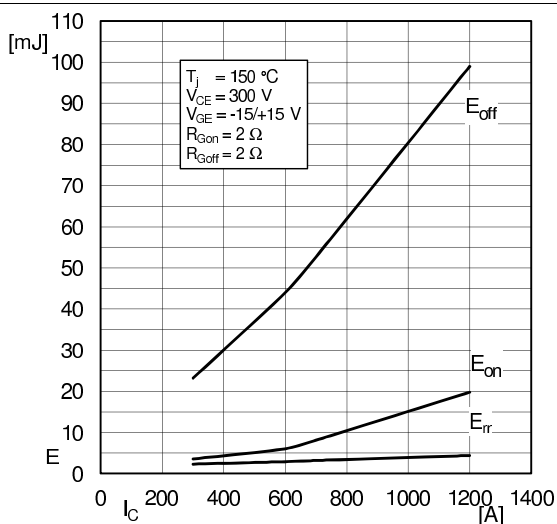


Fig. 6: Typ. turn-on /-off energy = $f(I_C)$

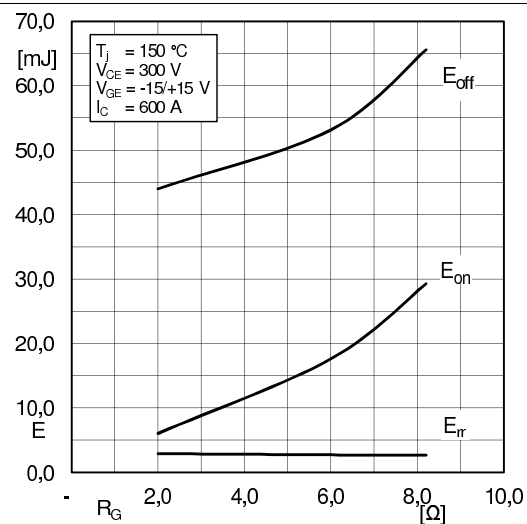


Fig. 8: Typ. turn-on /-off energy = $f(R_G)$

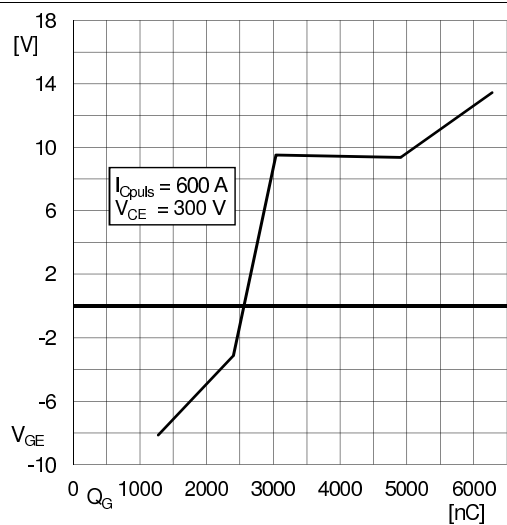


Fig. 10: Gate charge characteristic

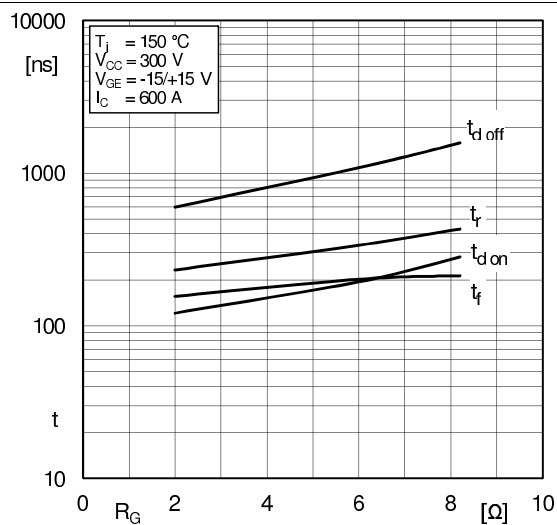


Fig. 12: Typ. switching times vs. gate resistor R_G

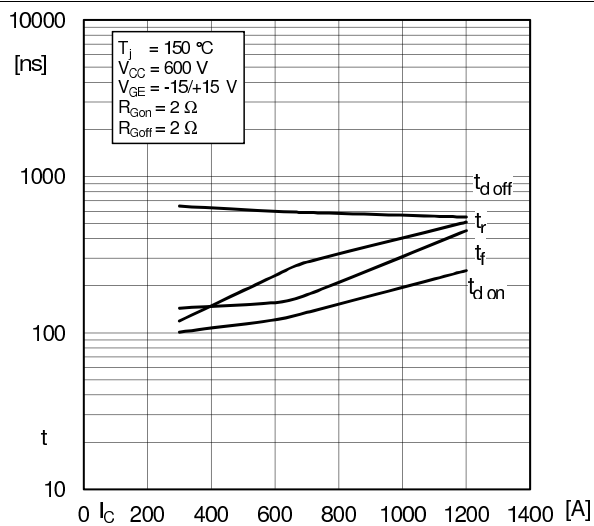


Fig. 14: Typ. switching times vs. I_C

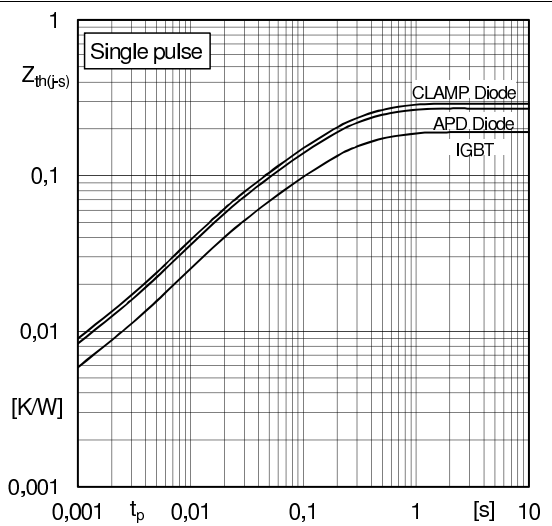
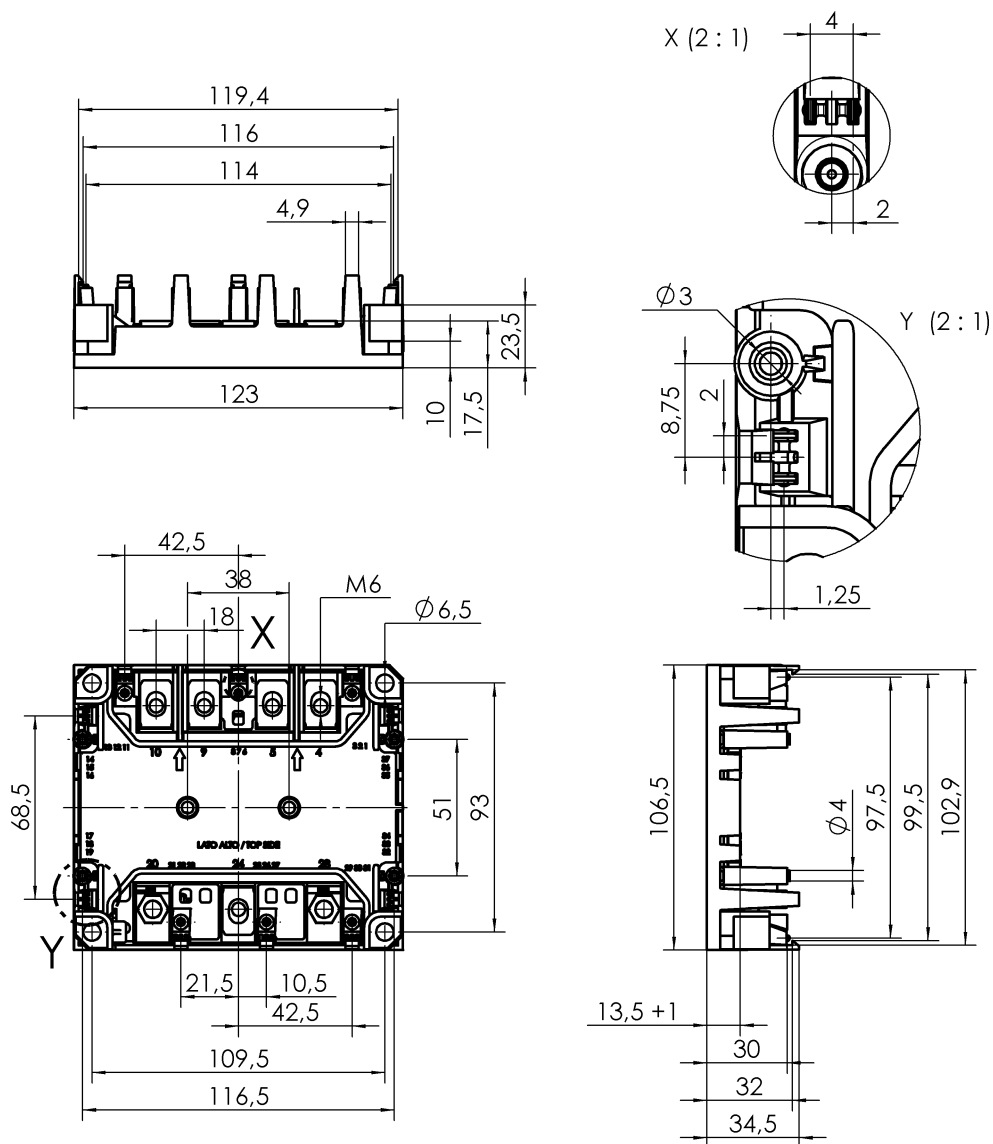
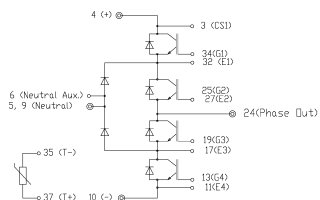


Fig. 15 Typ. IGBTs and DIODEs transient thermal impedance



SKiM 4



MLI

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.